### 捷多邦,专业PCB打样**\$N54州C可574**出**\$N**74HCT574 OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

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- Inputs Are TTL-Voltage Compatible
- High-Current 3-State Noninverting Outputs Drive Bus Lines Directly or up to 15 LSTTL Loads
- Bus-Structured Pinout
- Package Options Include Plastic Small-Outline (DW), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

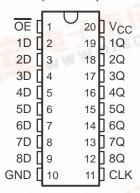
### description

These octal edge-triggered D-type flip-flops feature 3-state outputs designed specifically for bus driving. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

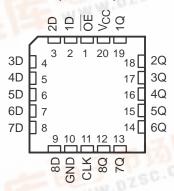
The eight flip-flops enter data on the low-to-high transition of the clock (CLK) input.

A buffered output-enable ( $\overline{OE}$ ) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

SN54HCT574...J OR W PACKAGE SN74HCT574...DW, N, OR PW PACKAGE (TOP VIEW)



SN54HCT574 . . . FK PACKAGE (TOP VIEW)



OE does not affect the internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54HCT574 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74HCT574 is characterized for operation from –40°C to 85°C.

### FUNCTION TABLE (each flip-flop)

	INPUTS	OUTPUT	
OE	CLK	D	Q
L	1	Н	Н
L	$\uparrow$	L	L
L	H or L	X	Q <sub>0</sub>
C.HC	X	Χ	Z

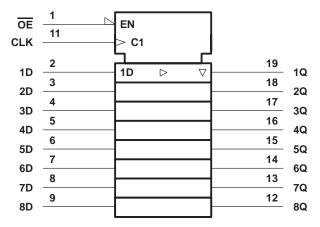
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### SN54HCT574, SN74HCT574 OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

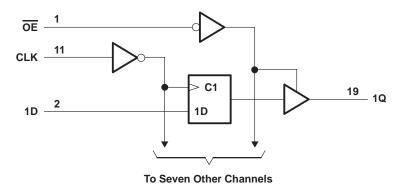
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### logic symbol†



<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

#### logic diagram (positive logic)



### absolute maximum ratings over operating free-air temperature range‡

Supply voltage range, V <sub>CC</sub>	0.5 V to 7 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ ) (see Note	e 1) ±20 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> ) (see	Note 1) ±20 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±35 mA
Continuous current through V <sub>CC</sub> or GND	±70 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): DW μ	package 97°C/W
N pac	ckage 67°C/W
PW p	ackage 128°C/W
Storage temperature range, T <sub>stg</sub>	

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

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### recommended operating conditions

			SN	SN54HCT574			SN74HCT574		
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2	3	7	2			V
V <sub>IL</sub>	Low-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	0	Q	0.8	0		0.8	V
٧ <sub>I</sub>	Input voltage		0	Ċ	VCC	0		VCC	V
VO	Output voltage		0 <	2	Vcc	0		VCC	V
t <sub>t</sub>	Input transition (rise and fall) time		0		500	0		500	ns
TA	Operating free-air temperature		-55		125	-40		85	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V	Т	A = 25°C	;	SN54H0	CT574	SN74H	CT574	UNIT	
PARAMETER			vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII	
Vari	VI = VIH or VIL	I <sub>OH</sub> = -20 μA	4.5 V	4.4	4.499		4.4		4.4		V	
Voн	AI = AIH OL AIL	$I_{OH} = -6 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		٧	
Voi	\/ı = \/ or \/	I <sub>OL</sub> = 20 μA	4.5 V		0.001	0.1		0.1		0.1	V	
VOL	$\Lambda I = \Lambda IH \text{ or } \Lambda I\Gamma$	$I_{OL} = 6 \text{ mA}$	4.5 V	4.5 V		0.17	0.26		0.4		0.33	٧
lj	$V_I = V_{CC}$ or 0		5.5 V		±0.1	±100		±1000		±1000	nA	
loz	$V_O = V_{CC}$ or 0		5.5 V		±0.01	±0.5	4	±10		±5	μΑ	
Icc	$V_I = V_{CC}$ or 0,	IO = 0	5.5 V			8	2	160		80	μΑ	
Δl <sub>CC</sub> †	One input at 0.5 V or 2.4 V, Other inputs at 0 or V <sub>CC</sub>		5.5 V		1.4	2.4	OYY	3		2.9	mA	
Ci			4.5 V to 5.5 V		3	10		10		10	pF	

<sup>†</sup> This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

## timing requirements over recommended operating free-air temperature range (unless otherwise noted)

		Vaa	T <sub>A</sub> = 2	25°C	SN54H	CT574	SN74H	CT574	UNIT	
		VCC	MIN	MAX	MIN	MAX	MIN	MAX	UNIT	
f	Clock frequency	4.5 V	0	30	0	20	0	24	MHz	
fclock		5.5 V	0	33	0	22	0	27	IVII IZ	
	Pulse duration, CLK high or low	4.5 V	16		24	F	20		20	
t <sub>W</sub>		5.5 V	14		22 🗸	5	18		ns	
Γ.	Setup time, data before CLK↑	4.5 V	20		30		25			
t <sub>su</sub>		5.5 V	17		27		23		ns	
<b>.</b>	Hold time, data after CLK↑	4.5 V	5		5		5		20	
th		5.5 V	5		5		5		ns	



### SN54HCT574, SN74HCT574 OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

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# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vaa	T,	λ = 25°C	;	SN54H	CT574	SN74H	CT574	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
f			4.5 V	30	36		20		24		MHz	
f <sub>max</sub>			5.5 V	33	40		22		27		IVII IZ	
	CLK	Any Q	4.5 V		30	36		54		45	ns	
<sup>t</sup> pd	CLK	Ally Q	5.5 V		25	32		48		41	115	
+	ŌĒ		Any Q	4.5 V		26	30	.<	45		38	ns
t <sub>en</sub>		Ally Q	5.5 V		23	27	(0)	41		34	115	
+	<del></del>	OE Any Q	4.5 V		23	30	Pa	45		38	ns	
<sup>t</sup> dis	OE OE		5.5 V		22	27	) V <sub>G</sub>	41		34	115	
+.		Any O	4.5 V		10	12		18		15	ns	
t <sub>t</sub>		Any Q	5.5 V		9	11		16		14	115	

# switching characteristics over recommended operating free-air temperature range, $C_L$ = 150 pF (unless otherwise noted) (see Figure 1)

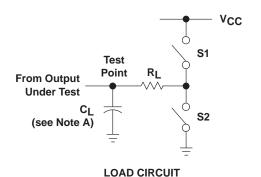
PARAMETER	FROM	FROM TO		T,	չ = 25°C	;	SN54H	CT574	SN74H	CT574	UNIT
PARAMETER	(INPUT)	INPUT) (OUTPUT)	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
f			4.5 V	30	36		20		24		MHz
f <sub>max</sub>			5.5 V	33	40		22	14	27		IVII IZ
	CLK	Any Q	4.5 V		40	53		<b>2</b> 80		66	ns
<sup>t</sup> pd		Ally Q	5.5 V		35	47		71		60	115
	ŌĒ	Any O	4.5 V		34	47	, '0,	71		59	no
t <sub>en</sub>		Any Q	5.5 V		29	39	<sup>a</sup> qc	94		78	ns
+.		Any Q	4.5 V		18	42	40	63		53	ns
t <sub>t</sub>	Any C	Ally Q	5.5 V		16	38		57		48	115

### operating characteristics, T<sub>A</sub> = 25°C

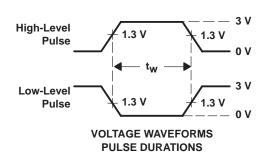
	PARAMETER	TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance per flip-flop	No load	93	pF

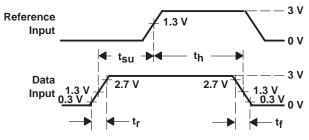
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#### PARAMETER MEASUREMENT INFORMATION

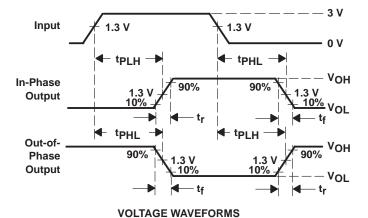


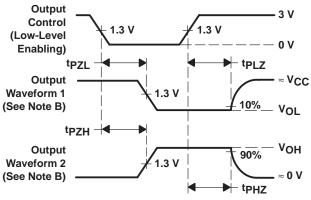
ΡΔΡΔΙ	METER	RL	CL	S1	S2
	tPZH	1 kΩ	50 pF	Open	Closed
t <sub>en</sub>	tPZL	1 K32	150 pF	Closed	Open
4	tPHZ	1 kΩ	50 pF	Open	Closed
<sup>t</sup> dis	tPLZ	1 K22	30 pr	Closed	Open
t <sub>pd</sub> or	t <sub>t</sub>		50 pF or 150 pF	Open	Open





VOLTAGE WAVEFORMS
SETUP AND HOLD AND INPUT RISE AND FALL TIMES





VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES FOR 3-STATE OUTPUTS

NOTES: A. C<sub>I</sub> includes probe and test-fixture capacitance.

PROPAGATION DELAY AND OUTPUT RISE AND FALL TIMES

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_f = 6$  ns.
- D. For clock inputs,  $f_{\mbox{max}}$  is measured when the input duty cycle is 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F. tpl 7 and tpH7 are the same as tdis.
- G. tpzL and tpzH are the same as ten.
- H. tplH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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